

NUWC-NPT Technical Report 10,840  
15 September 1997

# Evaluation of Small Tail Probabilities Directly from the Characteristic Function

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Surface Undersea Warfare Directorate

19971021 036

2025 RELEASE UNDER E.O. 14176



**Naval Undersea Warfare Center Division  
Newport, Rhode Island**

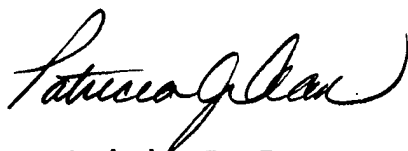
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## PREFACE

The work described in this report was sponsored by the Independent Research Program of the Naval Undersea Warfare Center Division, Newport, RI, under Project No. B100077, "Near-Optimum Detection of Random Signals with Unknown Locations, Structure, Extent, and Strengths," principal investigator Albert H. Nuttall (Code 311). The independent research program is funded by the Office of Naval Research; the Naval Undersea Warfare Center Division Newport program manager is Stuart C. Dickinson (Code 102).

The technical reviewer for this report was Paul M. Baggenstoss (Code 2121).

Reviewed and Approved: 15 September 1997



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# REPORT DOCUMENTATION PAGE

Form Approved  
OMB No. 0704-0188

Public reporting burden for this collection of information is estimated to average 1 hour per response, including the time for reviewing instructions, searching existing data sources, gathering and maintaining the data needed, and completing and reviewing the collection of information. Send comments regarding this burden estimate or any other aspect of this collection of information, including suggestions for reducing this burden, to Washington Headquarters Services, Directorate for Information Operations and Reports, 1215 Jefferson Davis Highway, Suite 1204, Arlington, VA 22202-4302, and to the Office of Management and Budget, Paperwork Reduction Project (0704-0188), Washington, DC 20503.

1. AGENCY USE ONLY (Leave blank)	2. REPORT DATE 15 September 1997	3. REPORT TYPE AND DATES COVERED Progress
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4. TITLE AND SUBTITLE Evaluation of Small Tail Probabilities Directly from the Characteristic Function	5. FUNDING NUMBERS PE 0601152N
6. AUTHOR(S) Albert H. Nuttall	

7. PERFORMING ORGANIZATION NAME(S) AND ADDRESS(ES) Naval Undersea Warfare Center Division 1176 Howell Street Newport, Rhode Island 02841-1708	8. PERFORMING ORGANIZATION REPORT NUMBER NUWC-NPT TR 10,840
--	---

9. SPONSORING/MONITORING AGENCY NAME(S) AND ADDRESS(ES) Office of Naval Research 800 North Quincy Street, BCT 1 Arlington, VA 22217-5000	10. SPONSORING/MONITORING AGENCY REPORT NUMBER
---	---

11. SUPPLEMENTARY NOTES

12a. DISTRIBUTION / AVAILABILITY STATEMENT  Approved for public release; distribution is unlimited.	12b. DISTRIBUTION CODE
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13. ABSTRACT (Maximum 200 words)

An efficient, fast, and accurate Fourier transform technique for obtaining small tail probabilities for both the probability density function and the exceedance distribution function, directly from the characteristic function, is derived and demonstrated numerically for several examples. The method is especially useful when analytic or asymptotic expressions for the probabilities are unavailable or unknown.

By choosing the shift parameter  $r$  close to the highest singularity of the characteristic function in the complex plane, very small values of the tail probabilities of the density function and exceedance distribution function can be realized. The cost in this approach is that the sampling increment must then be taken small, in order to avoid aliasing. Finer sampling necessitates more computer time and effort, but it does not require more storage;

14. SUBJECT TERMS Tail Probabilities                      Characteristic Function Probability Density                    Exceedance Distribution Fast Fourier Transform                Aliasing	15. NUMBER OF PAGES 54
16. PRICE CODE	

17. SECURITY CLASSIFICATION OF REPORT Unclassified	18. SECURITY CLASSIFICATION OF THIS PAGE Unclassified	19. SECURITY CLASSIFICATION OF ABSTRACT Unclassified	20. LIMITATION OF ABSTRACT SAR
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rather, prealiasing can be advantageously employed to keep the fast Fourier transform size at reasonable values. The fast Fourier transform size has no effect upon the errors caused by aliasing and truncation; rather, the size merely controls the spacing at which the probability density function and exceedance distribution function outputs are calculated. Tail probabilities in the E-50 range are readily available with a computer limited to 15 significant decimal digits.

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## LIST OF ABBREVIATIONS AND SYMBOLS

$a_n$	Real part of location of a singularity
$b_n$	Imaginary part of location of a singularity
$b_1$	Minimum imaginary part of singularity locations
$c$	Additive real constant
$C$	Contour of integration, equation (17)
CF	Characteristic function, equation (1)
EDF	Exceedance distribution function, equation (17)
$E(u)$	Exceedance distribution function of $x$ , equation (17)
$\underline{E}(u)$	Auxiliary function, equation (19)
$\tilde{E}(u)$	Periodic function, equation (21)
$f(\xi)$	Characteristic function of $x$ , equation (1)
$f_+(\xi)$	Characteristic function of positive- $u$ part of $p(u)$
$f_-(\xi)$	Characteristic function of negative- $u$ part of $p(u)$
$\tilde{f}_m$	Finite sequence of samples, equation (12)
FFT	Fast Fourier transform, equation (13)
Im	Imaginary part, equation (2)
$N$	Size of FFT, equation (13)
$N_f$	Integer in the noise region, equation (25)
PDF	Probability density function, equation (1)
Prob	Probability
$p(u)$	Probability density function of $x$ , equation (1)
$\underline{p}(u)$	Auxiliary function, equation (6)
$\tilde{p}(u)$	Periodic function, equation (7)
$r$	Real shift in path of $\xi$ integration, equation (4)
Re	Real part, equations (9), (10), (21)

LIST OF ABBREVIATIONS AND SYMBOLS (Cont'd)

$u_n$	General sampling point, equation (15)
$x$	Random variable
$\Delta_u$	Increment in $u$ , equation (14)
$\Delta_x$	Sampling increment, equations (7), (21)
$\epsilon_m$	Weighting sequence, equations (10), (21)
<b>bold</b>	Random variable

**EVALUATION OF SMALL TAIL PROBABILITIES  
DIRECTLY FROM THE CHARACTERISTIC FUNCTION**

**INTRODUCTION**

Given the characteristic function (CF)  $f(\xi)$  of a random variable  $x$ , the corresponding probability density function (PDF)  $p(u)$  can be found analytically by the Fourier transform

$$p(u) = \frac{1}{2\pi} \int_{-\infty}^{\infty} d\xi \exp(-iu\xi) f(\xi) . \quad (1)$$

The CF  $f(\xi)$  exists for all real  $\xi$  because the area under nonnegative PDF  $p(u)$  is unity. However, when integral (1) cannot be accomplished in closed form, it is often necessary to resort to a numerical technique, namely, the fast Fourier transform (FFT) to obtain approximate values of PDF  $p(u)$ .

Similarly, the exceedance distribution function (EDF),  $E(u) = \text{Prob}(x > u) = \int_u^{\infty} dt p(t)$ , corresponding to CF  $f(\xi)$ , is available by the Fourier transform (reference 1, equation (4.14) or reference 2, page 3)

$$E(u) = \frac{1}{2} + \frac{1}{\pi} \int_0^{\infty} \frac{d\xi}{\xi} \text{Im} \left( f(\xi) \exp(-iu\xi) \right) . \quad (2)$$

If this latter integral (2) cannot be done in closed form, or if the indefinite integral of PDF  $p(u)$  is unavailable, an efficient

numerical technique employing the FFT can again be utilized (references 2 through 4).

However, there is an inherent limitation in the numerical approximations to integrals (1) and (2) in their current forms, as integrals along the real  $\xi$ -axis. Both require sampling and summing integrands with values in the neighborhood of unity and relying on the cancellation of complex plus-and-minus values (contributed by the oscillating exponential  $\exp(-iu\xi)$ ) to reach very small values on the tails of the PDF  $p(u)$  or EDF  $E(u)$  for large  $u$ . If the computer being used is limited to  $D$  significant decimal digits, then the small tail probabilities calculated for  $p(u)$  or  $E(u)$ , which are less than approximately  $10^{-D}$ , are useless because these values are buried in the inherent round-off noise.

In this report, an efficient technique for obtaining small tail probabilities, significantly less than  $10^{-D}$ , is presented for both the PDF  $p(u)$  and the EDF  $E(u)$ . The basic idea is to move the contour of integration into the complex  $\xi$ -plane; however, care must then be taken to control the aliasing that always accompanies equispaced sampling, which in turn, is required for efficient use of an FFT. Examples of the proposed technique are presented for both the PDF and the EDF. Values of small tail probabilities in the  $10^{-50}$  range are readily achieved using a computer with  $D = 15$  significant decimal digits.

## DEVELOPMENT OF TECHNIQUE FOR PDF

### MOVEMENT OF CONTOUR FOR PDF

The CF  $f(\xi)$  follows from the PDF  $p(u)$  according to the inverse Fourier transform

$$\begin{aligned} f(\xi) &= \int_{-\infty}^{\infty} du \exp(i\xi u) p(u) \\ &= \int_{-\infty}^0 du \exp(i\xi u) p(u) + \int_0^{\infty} du \exp(i\xi u) p(u) \equiv f_{-}(\xi) + f_{+}(\xi) . \quad (3) \end{aligned}$$

The component  $f_{-}(\xi)$ , corresponding to  $u \leq 0$ , is analytic for  $\xi_i < 0$  because  $\exp(-\xi_i u)$  is bounded for  $u \leq 0$ . The decay of  $p(u)$  as  $u \rightarrow -\infty$  is arbitrary.

It is presumed that the PDF  $p(u)$  has already been shifted on the  $u$ -axis so that it is virtually zero for  $u < 0$ , yet is packed as closely as possible to the origin at abscissa values near  $u = 0+$ . This condition can be accomplished by adding a real constant  $c$  to the random variable under investigation. Addition of a constant  $c$  corresponds to multiplication of the corresponding CF by the factor  $\exp(ic\xi)$ ; this factor is presumed to be present in the given CF  $f(\xi)$ . The constant  $c$  can be positive or negative, depending on the desired direction of shift of a given PDF, so as to make  $p(u)$  essentially nonzero only in the positive neighborhood of  $u = 0$ .

This section focuses on the positive tail of PDF  $p(u)$ . It is presumed that  $p(u)$  decays according to  $u^\alpha \exp(-\beta u)$  as  $u \rightarrow +\infty$ ,  $\beta > 0$ . Then, the locations  $\xi_n = a_n - i b_n$  of all singularities of  $f_+(\xi)$  must satisfy  $b_n > 0$  for all  $n$ . Let  $b_1 = \min\{b_n\}$ , without loss of generality. Then,  $p(u) \exp(ru)$  decays exponentially as  $u \rightarrow +\infty$ , provided that real constant  $r < b_1$ . Accordingly, the Fourier relation in equation (1) can be written as

$$p(u) = \frac{1}{2\pi} \int_{-\infty - ir}^{\infty - ir} d\xi \exp(-iu\xi) f(\xi), \quad 0 < r < b_1. \quad (4)$$

This path of integration passes through the horizontal strip of analyticity between the real  $\xi$ -axis and the highest singularity of  $f(\xi)$  in the lower-half  $\xi$ -plane.

For example, PDF  $p(u) = 1.5 \exp(-u) - \exp(-2u)$ , for  $u > 0$  has CF  $f(\xi) = 1.5/(1-i\xi) - 1/(2-i\xi)$ , with poles at  $\xi = -i$  and  $\xi = -i2$ . Thus,  $a_1 = 0$ ,  $b_1 = 1$ ,  $a_2 = 0$ ,  $b_2 = 2$ , and  $r < 1$ . As a second example,  $p(u) = u \exp(-u)$ , for  $u > 0$  has  $f(\xi) = 1/(1-i\xi)^2$  with  $a_1 = 0$ ,  $b_1 = 1$ , for which  $r < 1$ . Finally, Gaussian PDF  $p(u) = (2\pi)^{-1/2} \exp[-(u-c)^2/2]$  has CF  $f(\xi) = \exp(-\xi^2/2 + ic\xi)$ , which has no singularities anywhere in the finite  $\xi$ -plane. Then,  $r$  can be chosen arbitrarily, positive or negative. (Positive constant  $c$  is taken as small as possible, subject to PDF value  $p(0)$  being sufficiently small, as discussed earlier.)

Upon making the substitution  $x = \xi + ir$  in equation (4), it follows that

$$p(u) = \exp(-ru) \underline{p}(u) , \quad (5)$$

where auxiliary function

$$\underline{p}(u) \equiv \frac{1}{2\pi} \int_{-\infty}^{\infty} dx \exp(-iux) f(x - ir) . \quad (6)$$

The real function  $\underline{p}(u)$  is nonnegative for all  $u$ , but it may not have unit area. The relations in equations (5) and (6) are exact, even if the path of integration is very close to the highest singularity of  $f(x - ir)$  in the lower-half  $x$ -plane at  $x_1 = a_1 - i(b_1 - r)$ .

By writing equation (5) in the form  $\underline{p}(u) = p(u) \exp(ru)$ , it is seen that the closer  $r$  is taken to  $b_1$ , the less decay there is in  $\underline{p}(u)$  for positive  $u$ . This property makes  $\underline{p}(u)$  a wider function of  $u$  and brings some of the originally very small values of  $\underline{p}(u)$  up to moderate levels; of course, the exponential decay of  $\underline{p}(u)$  will eventually take over, but it will be shifted to larger  $u$  values before becoming dominant. Thus, larger values of  $r$  (nearer  $b_1$ ) enable investigation of deeper tails of  $\underline{p}(u)$  than possible when  $r = 0$ , namely, using the real  $\xi$ -axis in equation (4).

Because PDF  $p(u) \approx 0$  for  $u < 0$ , the same is true for  $\underline{p}(u)$ , according to equation (5). Also, the essential nonzero region of

$p(u)$  is in the positive neighborhood of  $u = 0$ .

(If the negative tail of random variable  $x$  is of interest, consider the variable  $y = T - x$ , for which the PDF is  $p_y(u) = p_x(T - u)$ . Real constant  $T$  is taken just large enough that  $y$  is essentially nonzero only in the positive neighborhood of zero. Then, the CF of interest is  $f_y(\xi) = \exp(i\xi T) f_x(-\xi)$  instead of  $f_x(\xi)$ .)

#### SAMPLING AND ALIASING FOR PDF

Fourier relation (6) for widened function  $p(u)$  is evaluated approximately by sampling at increment  $\Delta_x$  for all  $x$ . (Truncation errors are discussed below.) The result is

$$p(u) \cong \frac{\Delta_x}{2\pi} \sum_{m=-\infty}^{\infty} \exp(-ium\Delta_x) f(m\Delta_x - ir) \equiv \tilde{p}(u) \quad \text{for all } u. \quad (7)$$

The latter real function,  $\tilde{p}(u)$ , is periodic in  $u$ , with period  $2\pi/\Delta_x$ . In fact, it is the aliased version of  $p(u)$ :

$$\tilde{p}(u) = \sum_{m=-\infty}^{\infty} p\left(u - m \frac{2\pi}{\Delta_x}\right) \quad \text{for all } u. \quad (8)$$

For  $\tilde{p}(u)$  to be a good approximation to  $p(u)$  in the positive neighborhood of  $u = 0$ , the aliasing lobes of  $\tilde{p}(u)$  must be sufficiently separated so that the fundamental period, interval  $(0, 2\pi/\Delta_x)$ , is only slightly contaminated by the undesired lobes

contributed when  $m = \pm 1, \pm 2, \dots$ . (Recall that  $p(u)$  is essentially nonzero only in the positive neighborhood of  $u = 0$ .) This requirement can be checked by looking at one period of  $\tilde{p}(u)$ , namely,  $0 < u < 2\pi/\Delta_x$ , to determine if the skirts near  $u = 0+$  and  $u = 2\pi/\Delta_x-$  are sufficiently small. If not, sampling increment  $\Delta_x$  must be decreased. Then,  $\tilde{p}(u)$  will be a good approximation to  $p(u)$  in the interval  $(0, 2\pi/\Delta_x)$ .

It should be recalled that the closer  $r$  is taken to  $b_1$ , the less decay there is in  $p(u)$  (see equation (5)); that is,  $p(u)$  is wider in  $u$ , leading to more severe aliasing problems in equation (8), unless  $\Delta_x$  is additionally decreased, separating the lobes of  $\tilde{p}(u)$  farther apart. This additional decrease is an unavoidable consequence of investigating deeper tails of  $p(u)$  by relations (5) and (6).

The proximity of the path of integration in equation (6) to the nearest singularity of  $f(x - ir)$  does not require an additional decrease in sampling increment  $\Delta_x$ ; it is all accounted for in the widening effect of  $\exp(ru)$  upon  $p(u)$  in the function  $\tilde{p}(u) = \exp(ru) p(u)$  and the attendant more stringent alias-suppression requirement in equation (8).

A shortcut for the evaluation of equation (7) is available by taking advantage of the conjugate symmetry of  $f(x - ir)$ . In particular, from equation (3), it follows that  $f(-x - ir) = f^*(x - ir)$ . Then, equation (6) can be expressed as

$$p(u) = \frac{1}{\pi} \operatorname{Re} \int_0^{\infty} dx \exp(-iux) f(x - ir) , \quad (9)$$

and equation (7) can be expressed as

$$p(u) \cong \frac{\Delta_x}{\pi} \operatorname{Re} \sum_{m=0}^{\infty} \epsilon_m \exp(-ium\Delta_x) f(m\Delta_x - ir) = \tilde{p}(u) . \quad (10)$$

This function is the same function  $\tilde{p}(u)$  encountered in equation (7). The sequence  $\{\epsilon_m\}$  is  $\frac{1}{2}$  for  $m = 0$ , and 1 otherwise.

#### FFT CONSIDERATIONS FOR PDF

Periodic function  $\tilde{p}(u)$ , defined by equation (7), needs to be evaluated over one period only. In particular, because the function of interest,  $p(u)$ , is essentially nonzero only in the positive neighborhood of  $u = 0$ , attention is confined to values

$$\tilde{p}\left(\frac{2\pi}{\Delta_x} \frac{n}{N}\right) = \frac{\Delta_x}{2\pi} \sum_{m=-\infty}^{\infty} \exp(-i2\pi mn/N) f(m\Delta_x - ir) \quad \text{for } 0 \leq n \leq N-1. \quad (11)$$

However, because the exponential factor  $\exp(-i2\pi mn/N)$  treats all complex samples  $f(\{m + kN\}\Delta_x - ir)$  equally, regardless of the value of integer  $k$ , these samples can be collapsed (or prealiased) into a set of just  $N$  values according to

$$\tilde{f}_m \equiv \sum_{k=-\infty}^{\infty} f\left((m + kN)\Delta_x - ir\right) \quad \text{for } 0 \leq m \leq N-1 . \quad (12)$$

This process accounts for all the samples of  $f$  encountered in equation (11). FFT size  $N$  can be much smaller than the number of terms required in equation (12) to control and minimize truncation errors. Then, equation (11) can be written exactly as finite sum

$$\tilde{p}\left(\frac{2\pi}{\Delta_x} \frac{n}{N}\right) = \frac{\Delta_x}{2\pi} \sum_{m=0}^{N-1} \exp(-i2\pi mn/N) \tilde{f}_m \quad \text{for } 0 \leq n \leq N-1. \quad (13)$$

Because the  $N$  infinite sums required by equation (12) can never be conducted in practice, it is necessary to truncate them where  $|f(x - ir)|$  is sufficiently small. The effect of the resultant truncation errors can be observed in the  $u$  domain as a low-level oscillatory behavior when equation (13) is plotted. If this level is excessive, a smaller tolerance must be set on truncating equation (12), and additional values for larger  $|k|$  must be taken into account.

Operation (13) can be accurately and efficiently realized as an  $N$ -point FFT if  $N$  is taken as a power of 2. Observe that FFT size  $N$  does not affect the truncation error or the aliasing error; rather,  $N$  merely sets the spacing in variable  $u$  in equation (13), namely,

$$\Delta_u = \frac{2\pi}{N\Delta_x}, \quad (14)$$

at which output  $\tilde{p}(u)$  is obtained.

## PLOTTING PROCEDURE

It is recommended that output (13) be plotted over the full sweep of  $n$  values and observed for its near-origin behavior, aliasing, and truncation errors. Then, additive constant  $c$ , or sampling increment  $\Delta_x$ , or the truncation limits in equation (12), or any combination of the three can be modified, and the entire procedure repeated until all errors are acceptable. Also, regions of  $u$  where  $\tilde{p}(u)$  is below the inherent round-off error of the computer will appear with a white-noise strip of low-level values; this white-noise strip gives a measure of the relative errors of the values obtained for  $\tilde{p}(u)$  in the entire region  $0 < u < 2\pi/\Delta_x$ .

If the following points in the fundamental interval are defined according to

$$u_n = n \Delta_u = \frac{2\pi}{\Delta_x} \frac{n}{N} \quad \text{for } 0 \leq n \leq N-1, \quad (15)$$

then, the desired values of pdf  $p(u)$  are available from equations (5), (7), and (13) according to

$$\begin{aligned} p(u_n) &= \exp(-ru_n) \underline{p}(u_n) \approx \exp(-ru_n) \tilde{p}(u_n) \\ &= \exp(-ru_n) \frac{\Delta_x}{2\pi} \sum_{m=0}^{N-1} \exp(-i2\pi mn/N) \tilde{f}_m \quad \text{for } 0 \leq n \leq N-1. \end{aligned} \quad (16)$$

A plot of this approximation to  $p(u)$ , in conjunction with the relative error information obtained from the earlier plot of  $\tilde{p}$  in

equation (13), reveals the levels of PDF  $p(u)$  and the relative errors associated with different regions of  $u$ . If the lowest levels reached by equation (16) are not sufficiently small, parameter  $r$  in equations (4) and (12) must be increased and the plots of equations (13) and (16) must be repeated. As noted earlier, doing so will likely entail a decrease in sampling increment  $\Delta_x$  to control aliasing of a wider  $p(u)$ . A short trial-and-error procedure may be required.

## DEVELOPMENT OF TECHNIQUE FOR EDF

### MOVEMENT OF CONTOUR FOR EDF

The Fourier transform relating the EDF  $E(u) = \text{Prob}(x > u)$  to the CF  $f(\xi)$  can be written in the form

$$E(u) = \int_u^{\infty} dt p(t) = \frac{1}{i2\pi} \int_C d\xi \frac{f(\xi)}{\xi} \exp(-iu\xi) , \quad (17)$$

where contour  $C$  is the real  $\xi$ -axis, except that it passes below the singularity at  $\xi = 0$ . The comments regarding the corresponding PDF  $p(u)$  in equation (3) and sequel are directly relevant to equation (17). In particular, as in equation (4), the contour is moved to distance  $r$  below the real  $\xi$ -axis, where real constant  $r$  is less than the distance to the nearest singularity of  $f(\xi)$  in the lower-half  $\xi$ -plane to obtain

$$E(u) = \frac{1}{i2\pi} \int_{-\infty-ir}^{\infty-ir} d\xi \frac{f(\xi)}{\xi} \exp(-iu\xi) = \exp(-ru) \underline{E}(u) , \quad (18)$$

where auxiliary function

$$\underline{E}(u) \equiv \frac{1}{i2\pi} \int_{-\infty}^{\infty} dx \frac{f(x - ir)}{x - ir} \exp(-iux) . \quad (19)$$

Here, the substitution  $x = \xi + ir$  was used. Relation (19) is still a Fourier transform, although with a modified integrand.

The real function  $\underline{E}(u)$  is nonnegative for all  $u$ . Relations (18) and (19) are exact, even if the path of integration is very close to the highest singularity of  $f(x - ir)$  in the lower-half  $x$ -plane at  $x_1 = a_1 - i(b_1 - r)$ ,  $b_1 > 0$ .

By writing equation (18) in the form  $\underline{E}(u) = E(u) \exp(ru)$ , it is seen that the closer  $r$  is taken to  $b_1$ , the less decay there is in  $\underline{E}(u)$  for positive  $u$ . For  $u > 0$ ,  $\underline{E}(u)$  becomes a wider function of  $u$  and brings some of the originally very small values of  $E(u)$  up to moderate levels; of course, the exponential decay of  $\underline{E}(u)$  as  $u \rightarrow +\infty$  eventually takes over, but it is shifted to larger  $u$  values before becoming dominant. Thus, larger values of  $r$  (nearer  $b_1$ ) enable investigation of deeper tails of  $E(u)$  than possible when  $r = 0$ , namely, using the real  $\xi$ -axis in equation (17).

The dominant asymptotic behaviors of functions  $E(u)$  and  $\underline{E}(u)$  are as follows:

$$E(u) \propto \begin{cases} 1 & \text{as } u \rightarrow -\infty \\ \exp(-b_1 u) & \text{as } u \rightarrow +\infty \end{cases}, \quad \underline{E}(u) \propto \begin{cases} \exp(ru) & \text{as } u \rightarrow -\infty \\ \exp(ru - b_1 u) & \text{as } u \rightarrow +\infty \end{cases}. \quad (20)$$

By taking  $0 < r < b_1$ ,  $\underline{E}(u)$  decays to zero for both  $u \rightarrow \pm\infty$ . Taking  $r$  close to  $b_1$  keeps  $\underline{E}(u)$  at a high level (near  $\underline{E}(0)$ ) for an extended range of positive  $u$ . It also gives maximum decay to the left tail of  $\underline{E}(u)$ , which will be seen to be advantageous in terms of alias control. If  $\underline{E}(u)$  can be accurately calculated for

large positive  $u$ , then relation (18) will result in accurate evaluation of  $E(u)$  at very low levels of probability.

It is important to observe that, unlike the original EDF  $E(u)$ , the modified EDF  $\underline{E}(u)$  decays to zero as  $u \rightarrow +\infty$ ; the original EDF  $E(u)$  always approaches 1 as  $u \rightarrow -\infty$ . This feature of  $\underline{E}(u)$  allows the integral of equation (19) to be approximated by a sampling procedure and yet have controllable aliasing lobes.

#### SAMPLING AND ALIASING FOR EDF

Fourier relation (19) for modified EDF  $\underline{E}(u)$  is evaluated approximately by sampling at increment  $\Delta_x$  for all  $x$ . The result is

$$\begin{aligned} \underline{E}(u) &= \frac{1}{\pi} \operatorname{Re} \int_0^{\infty} dx \frac{f(x - ir)}{r + ix} \exp(-iux) = \\ &\approx \frac{\Delta_x}{\pi} \operatorname{Re} \sum_{m=0}^{\infty} \epsilon_m \frac{f(m\Delta_x - ir)}{r + im\Delta_x} \exp(-ium\Delta_x) \equiv \tilde{E}(u) \quad \text{for all } u. \quad (21) \end{aligned}$$

The latter real function,  $\tilde{E}(u)$ , is periodic in  $u$ , with period  $2\pi/\Delta_x$ ; in fact, it is the aliased version of  $\underline{E}(u)$ :

$$\tilde{E}(u) = \sum_{m=-\infty}^{\infty} \underline{E}\left(u - m \frac{2\pi}{\Delta_x}\right) \quad \text{for all } u. \quad (22)$$

For  $\tilde{E}(u)$  to be a good approximation to  $\underline{E}(u)$  in the positive neighborhood of  $u = 0$ , the aliasing lobes of  $\tilde{E}(u)$  must be

sufficiently separated so that the fundamental period, interval  $(0, 2\pi/\Delta_x)$ , is only slightly contaminated by the undesired lobes contributed when  $m = \pm 1, \pm 2, \dots$ . (Recall that  $\underline{E}(u)$  is essentially nonzero only in the neighborhood of  $u = 0$ ; see equation (20).) This aliasing requirement can be checked by looking at one period of  $\tilde{E}(u)$ , namely,  $0 < u < 2\pi/\Delta_x$ , to see if the skirts near  $u = 0+$  and  $u = 2\pi/\Delta_x-$  are sufficiently small. If they are not, sampling increment  $\Delta_x$  must be decreased. Then,  $\tilde{E}(u)$  can be made a good approximation to  $\underline{E}(u)$  in an interval of length  $(0, 2\pi/\Delta_x)$  located about  $u = 0$ .

From equations (18) and (21), interest is centered on

$$E(u) = \exp(-ru) \underline{E}(u) \cong \exp(-ru) \tilde{E}(u) \quad (23)$$

for  $u$  in the fundamental period of length  $2\pi/\Delta_x$  in the neighborhood of zero. Accurate results for EDF  $E(u)$  are obtained when  $\tilde{E}(u)$  has experienced insignificant aliasing, which is accomplished by choosing  $\Delta_x$  small enough. Because  $\underline{E}(u)$  for  $u > 0$  has purposely been stretched out over a wider  $u$  interval, by choice of  $r$ ,  $\Delta_x$  must be made quite small. Making  $\Delta_x$  quite small, however, is an inherent requirement for investigating very low levels of  $E(u)$  because these low levels are not realized until a considerable interval of  $u$  has been covered. In other words, the more stringent requirement on  $\Delta_x$  is not due to the particular procedure, but rather, due to the desire to investigate a wider range of positive  $u$  values, namely, those including very small

$E(u)$ . That procedure naturally requires a larger spacing of the aliasing lobes of  $\tilde{E}(u)$  to clear out a wider interval of  $u$  space so that the ever-present aliasing does not become intolerable.

#### FFT CONSIDERATIONS FOR EDF

Because  $\tilde{E}(u)$  has period  $2\pi/\Delta_x$ , its evaluation can be limited to one period. In particular, consider

$$\tilde{E}\left(\frac{2\pi}{\Delta_x} \frac{n}{N}\right) = \frac{\Delta_x}{\pi} \operatorname{Re} \sum_{m=0}^{\infty} \epsilon_m \frac{f(m\Delta_x - ir)}{r + im\Delta_x} \exp(-i2\pi mn/N) \text{ for } 0 \leq n \leq N-1. \quad (24)$$

Presuming that sampling increment  $\Delta_x$  is taken small enough to effectively eliminate aliasing, a plot of this complete period of  $\tilde{E}(u)$  reveals an interior region where the computer round-off noise is dominant.

If an integer in this noise region is defined as  $N_f$ , then the values of equation (24) in the range  $(0, N_f)$  can be used directly to get estimates of the desired EDF according to

$$E\left(\frac{2\pi}{\Delta_x} \frac{n}{N}\right) = \exp\left(-r \frac{2\pi}{\Delta_x} \frac{n}{N}\right) \underline{E}\left(\frac{2\pi}{\Delta_x} \frac{n}{N}\right) \cong \exp\left(-r \frac{2\pi}{\Delta_x} \frac{n}{N}\right) \tilde{E}\left(\frac{2\pi}{\Delta_x} \frac{n}{N}\right) \quad (25)$$

for  $0 \leq n \leq N_f$ . However, the values in the region  $N_f < n$  must be scaled differently because they should represent the negative region of  $E(u)$  just below the origin, that is,  $u < 0$ . The

correct scaling in this region is

$$\exp\left(r \frac{2\pi}{\Delta_x} - r \frac{2\pi}{\Delta_x} \frac{n}{N}\right) \tilde{E}\left(\frac{2\pi}{\Delta_x} \frac{n}{N}\right) \quad \text{for } N_f < n < N. \quad (26)$$

These scaled values are typically stored back in bins  $N_f < n < N$  and plotted at the upper end of the interval  $(0, 2\pi/\Delta_x)$ . However, this upper end of the plot must be recognized as the estimate of EDF  $E(u)$  just to the left of the origin, that is,  $u < 0$ .

Usually, only the values for  $0 \leq n \leq N_f$  are of interest because they encompass the small tail probability values of  $E(u)$ .

The infinite sum on  $m$  in equation (24) must be truncated where the magnitude of complex ratio  $f(m\Delta_x - ir)/(r + im\Delta_x)$  becomes insignificant. Values of this complex ratio for  $m \geq N$  are simply additively prealiased into bin  $m \text{ MODULO } N$ , thereby avoiding truncation error. Notice that FFT size  $N$  has no effect on accuracy; it merely controls the spacing  $\Delta_u = 2\pi/(N\Delta_x)$  of output values in equations (24) and (25).

## EXAMPLES

Four different characteristic functions are considered in this section. For each CF  $f(\xi)$ , the corresponding PDF  $p(u)$  is calculated and plotted, along with an error estimate. In the second half of this section, the corresponding EDFs  $E(u)$  are evaluated, in addition to an error estimate. Deeper tail probabilities than considered in these examples are possible through larger choices of the shift parameter  $r$ . All the FFT sizes were taken at  $N = 1024$  in this section.

### CHI-SQUARE PDF

The CF of interest is  $f(\xi) = (1 - i\xi)^{-10}$ , which corresponds to a random variable  $x$  that is composed of a sum of 20 independent, squared Gaussian random variables with zero mean and common variance  $\frac{1}{2}$ . Because  $x \geq 0$ , additive constant  $c$  is taken as zero.

Consider, first, the standard FFT approach (1) on this CF, that is, with shift parameter  $r = 0$ . The resultant PDF  $p(u)$  is displayed in figure 1, where sampling increment  $\Delta_x = 2\pi/80$  was used in equation (7) and sequel. The PDF  $p(u)$  decays until it reaches the inherent round-off noise of the computer, which is roughly  $E-15$  relative error (64-bit representations). Lower probability (density) estimates are not possible for this example with this standard FFT approach. The maximum abscissa (period) on this plot is  $2\pi/\Delta_x$ , which is 80 for the above choice of  $\Delta_x$ .

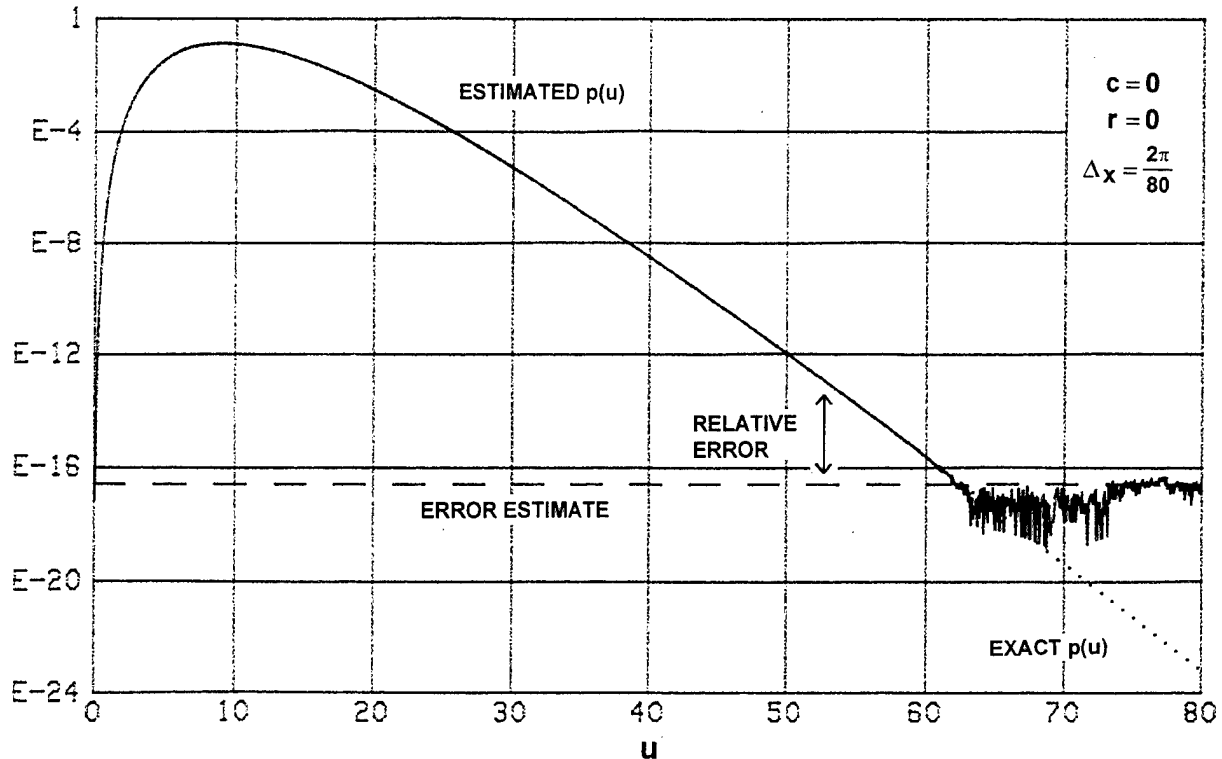


Figure 1. Chi-Square  $p(u)$  via Standard FFT Technique

Observe that  $p(u)$  drops from  $E-6$  to  $E-16$  in a span of values from  $u = 32$  to  $u = 61$ , that is, a span of 29 in  $u$ . To reach probability (density) level  $E-76$ , for example, an additional span of approximately  $6 * 29 = 174$  in  $u$  is required. To avoid aliasing, a new sampling increment satisfying  $61 + 174 = 2\pi/\Delta_x$ , namely,  $\Delta_x = 2\pi/235$ , is required. That is, a noise-free computer would have required  $\Delta_x = 2\pi/235$  to get to level  $E-76$  by the standard technique with  $r = 0$ .

On the other hand, using shift parameter value  $r = 0.7$ , along with  $c = 0$  and  $\Delta_x = 2\pi/240$ , the periodic function  $\tilde{p}(u)$ , defined in equation (7), is presented in figure 2. Naturally,  $\tilde{p}(u)$  has a relative error about E-15; furthermore, this small sampling increment  $\Delta_x$  is observed to be necessary to avoid aliasing at the right tail of  $\tilde{p}(u)$ .

When the results for  $\tilde{p}(u)$  are used in equation (16), the resultant estimate for the desired PDF  $p(u)$  is as shown in figure 3. The superposed dashed line is an error estimate, starting from E-12 near the top left and going to the noisy region at the bottom right end. The relative error of the estimated  $p(u)$  varies over the range of  $u$  values, gradually deteriorating to useless values for  $u > 200$ . However, approximately six significant decimal digits are still available at the E-50 probability level. For this example, the exact PDF  $p(u)$  is available and has also been plotted in figure 3; it overlies the estimated PDF until the probability values drop below E-75.

#### GAUSSIAN PDF

The normalized Gaussian CF is  $f(\xi) = \exp(-\xi^2/2 + ic\xi)$ , where additive constant  $c$  is taken as 2. With shift  $r = 7$  and sampling increment  $\Delta_x = 2\pi/20$ , the periodic function  $\tilde{p}(u)$  is as displayed in figure 4. The sampling increment could not have been taken much smaller without incurring aliasing. Also, the constant  $c$  is at its minimum value, just keeping positive values at  $u = 0+$ .

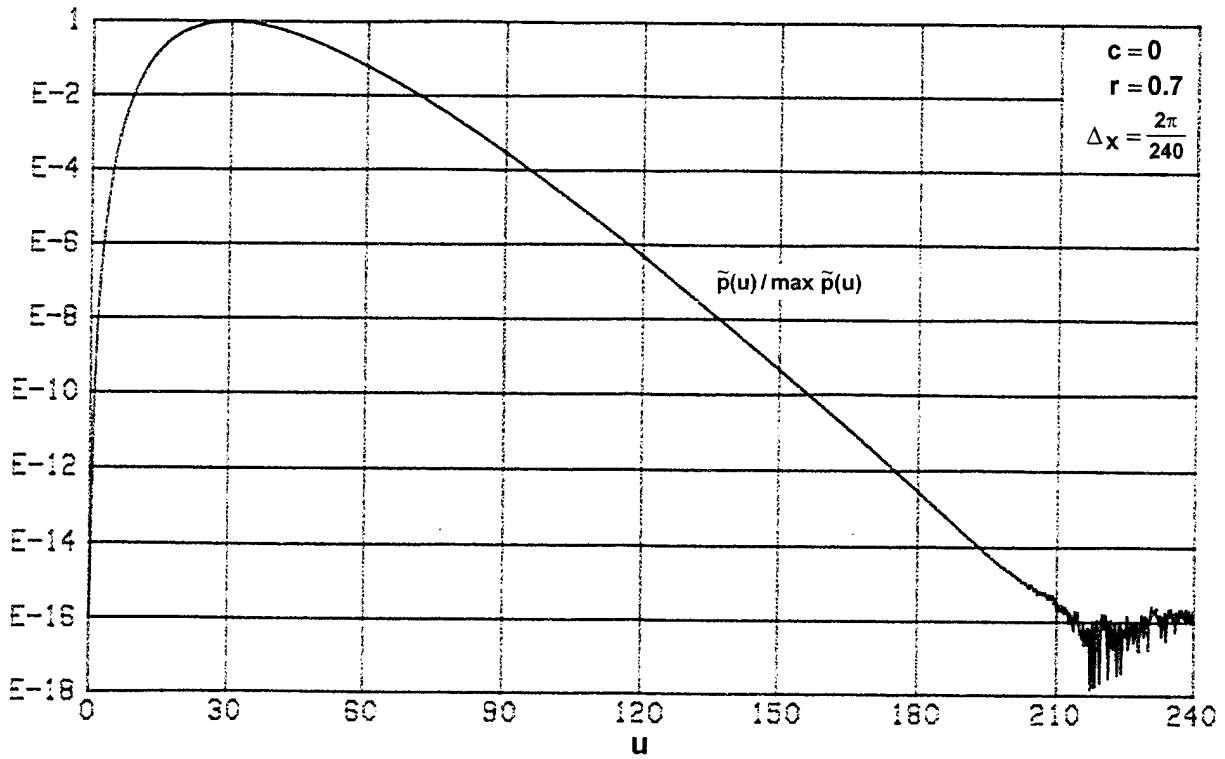


Figure 2. Chi-Square  $\tilde{p}(u)$

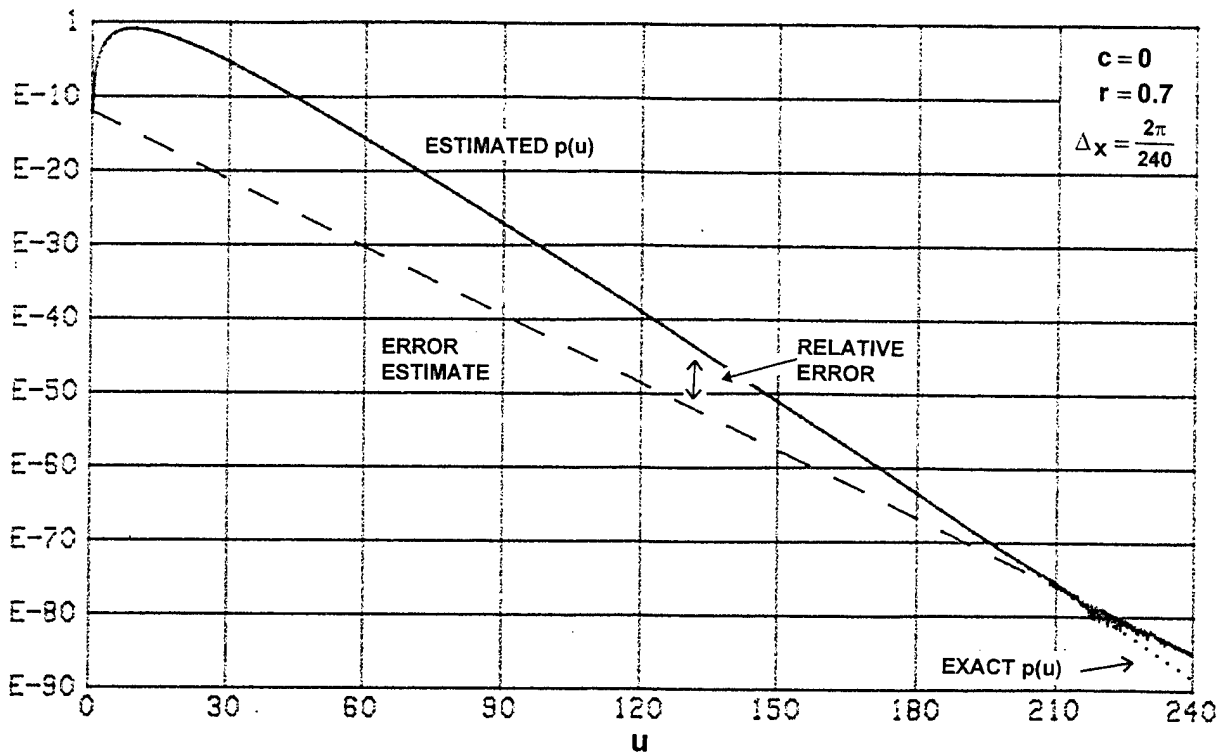


Figure 3. Chi-Square  $p(u)$

The corresponding estimated PDF  $p(u)$  is plotted in figure 5, along with the estimated error. The estimated error line joins the two noisy regions at each end of the interval  $(0,20)$ , which are easily located in  $\tilde{p}(u)$  in figure 4. For this example, there are approximately seven decimals of accuracy at the E-40 probability level. The exact PDF  $p(u)$  overlies the estimated PDF except at the edges of the interval  $(0,20)$ ; this type of result is again anticipated by the plot of figure 4.

#### BRANCH POINT PDF

The CF for this example has multiple branch points, namely,

$$f(\xi) = \prod_{n=1}^{10} (1 - i\xi/n)^{-\frac{1}{2}} . \quad (27)$$

This CF corresponds to the sum of 10 independent, squared zero-mean Gaussian random variables with different variances,  $1/(2n)$ . The corresponding PDF  $p(u)$  is not available in closed form.

The relatively slow decay of this CF, namely, as  $1900/\xi^5$ , forces numerous evaluations of equation (27) to be undertaken. In fact, with increment  $\Delta_x = 2\pi/200$ , over 160,000 complex samples were required until  $|f(\xi)|$  became sufficiently small to control the truncation error. Nevertheless, employment of prealiasing operation (12) enabled storage and execution of only an  $N = 1024$  point FFT according to equation (13).

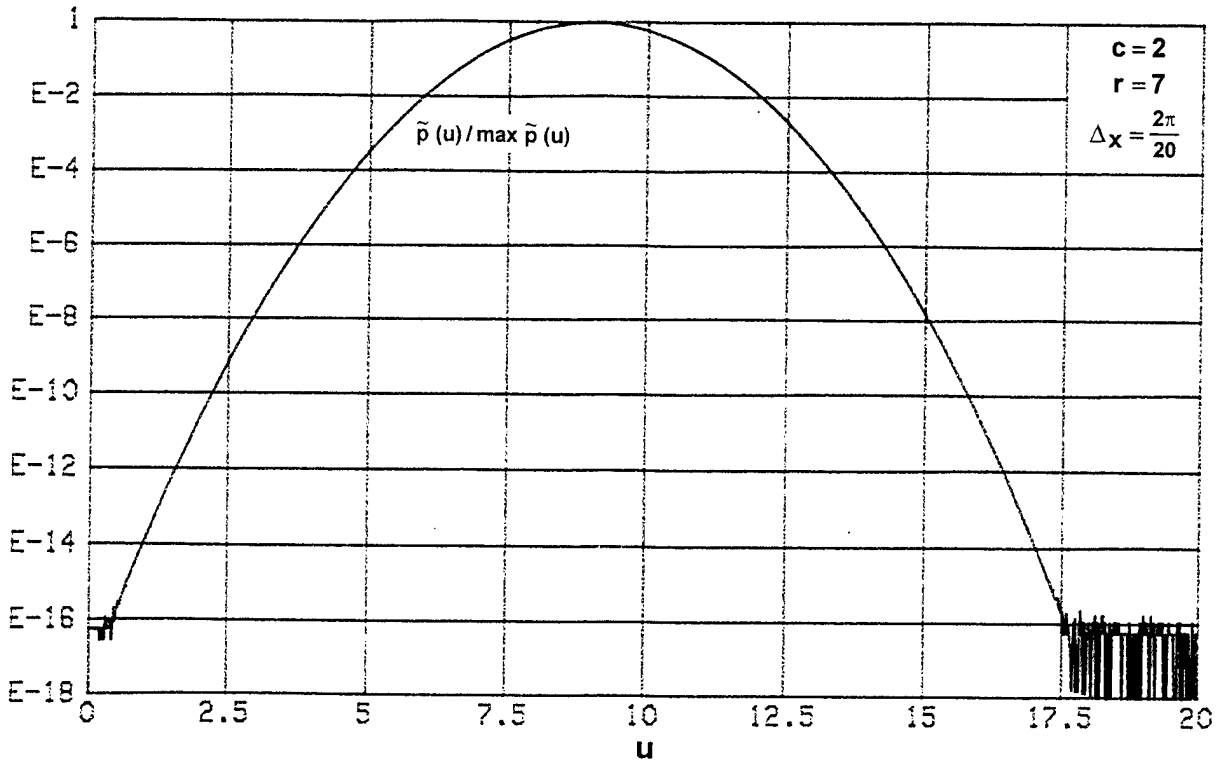


Figure 4. Gaussian  $\tilde{p}(u)$

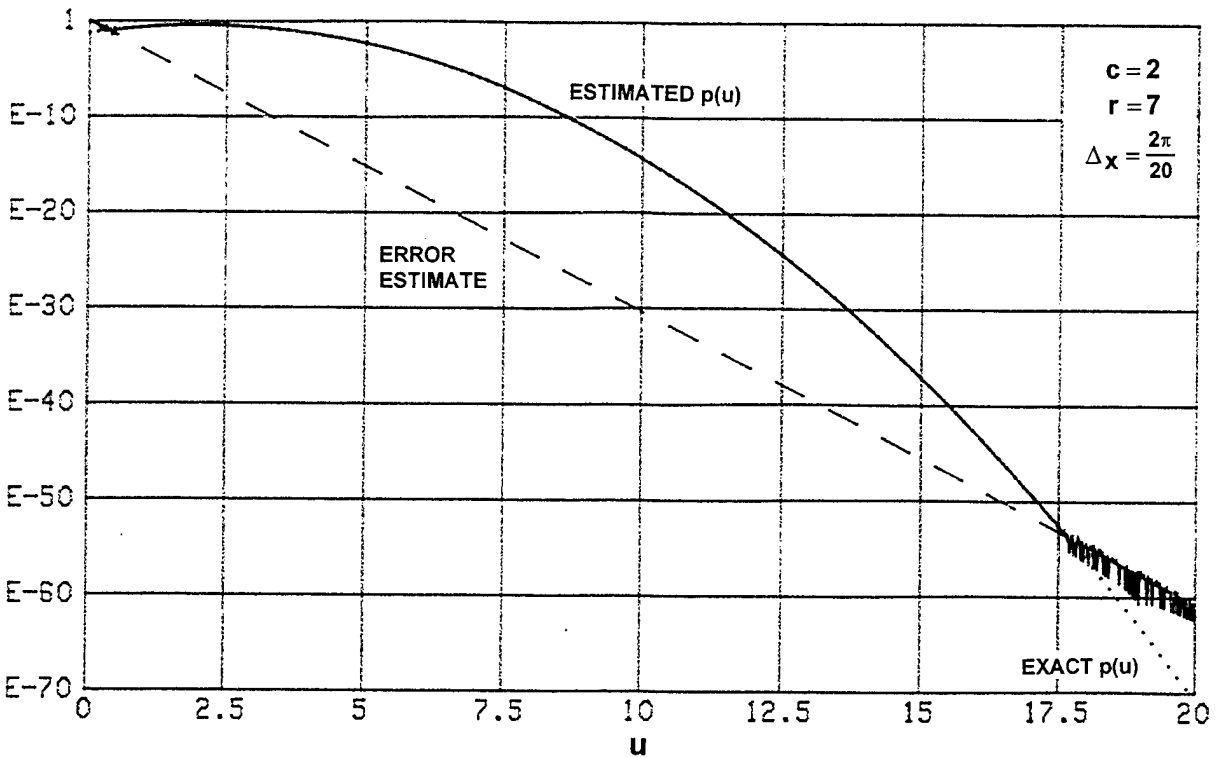


Figure 5. Gaussian  $p(u)$

The function  $\tilde{p}(u)$  resulting from operation (13) is displayed in figure 6 for shift  $r = 0.8$ . The corresponding estimated PDF  $p(u)$  is given in figure 7, along with the estimated error. The result for  $p(u)$  has approximately six digits of significance at the E-40 probability level.

#### ESSENTIAL SINGULARITY PDF

The last characteristic function of interest is

$$f(\xi) = \exp\left(i\xi \sum_{n=1}^{10} \frac{1}{1 - i\xi/n}\right) \prod_{n=1}^{10} (1 - i\xi/n)^{-1/2}. \quad (28)$$

This CF has branch points and essential singularities at  $\xi = -in$  and corresponds to a sum of 10 independent, squared Gaussian random variables with a common mean of 1 and different variances  $1/(2n)$ .

The exponential in equation (28) causes a more rapid decay with  $\xi$ ; in fact, only 200 samples of the CF were necessary at sampling increment  $\Delta_x = 2\pi/200$ , using shift  $r = 0.6$ , to control the truncation error. The resultant  $\tilde{p}(u)$ , plotted in figure 8, again has relative error in the E-15 range. The corresponding estimated PDF  $p(u)$  and its estimated error are displayed in figure 9. There are approximately five digits of significance at the E-40 probability level.

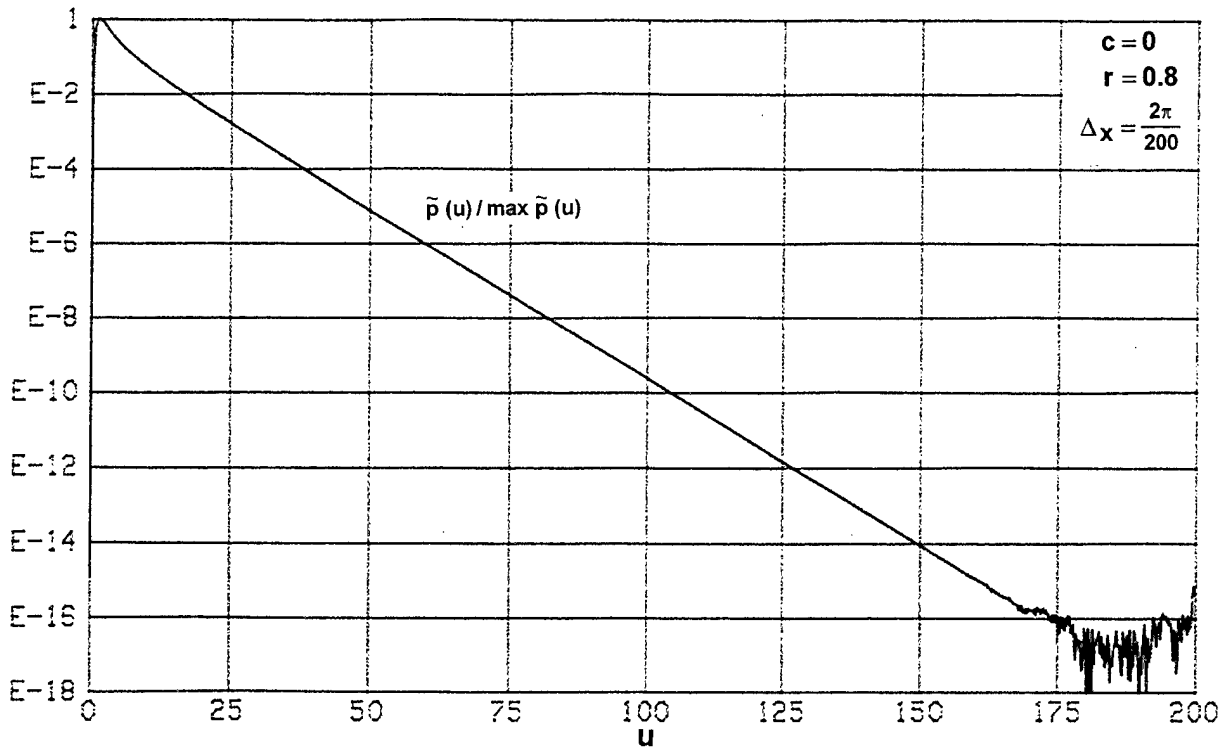


Figure 6. Branch Point  $\tilde{p}(u)$

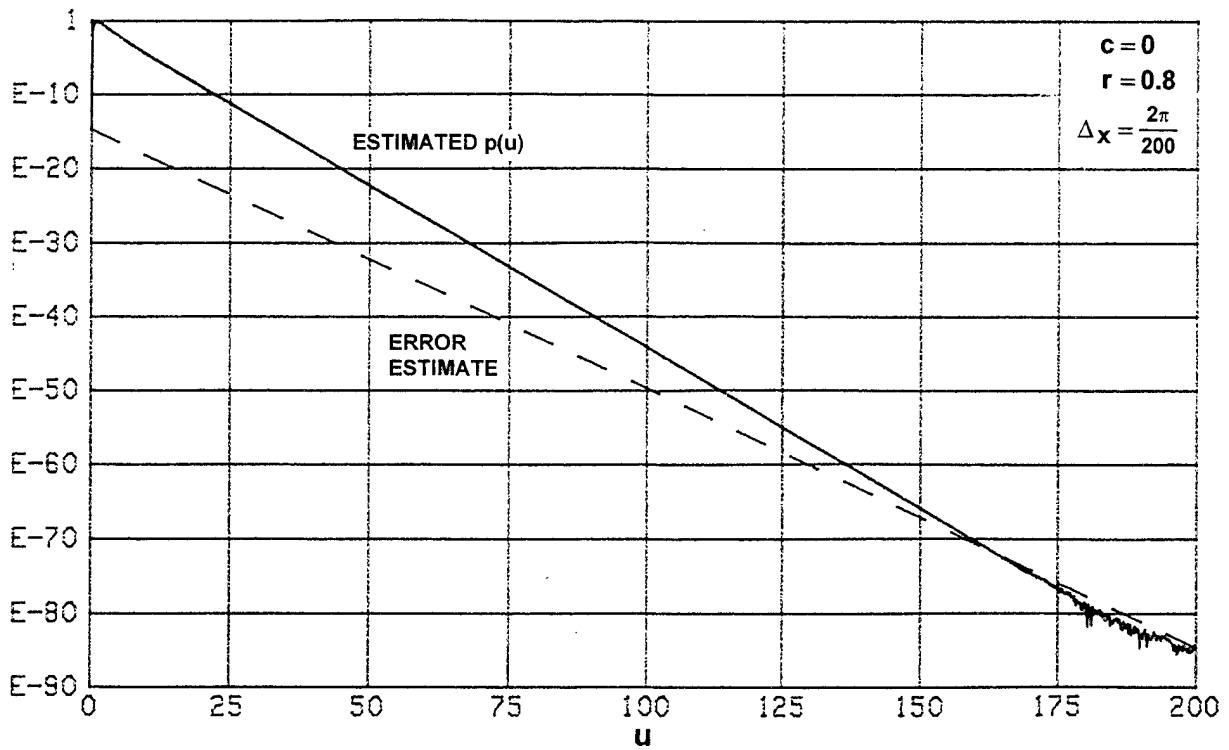


Figure 7. Branch Point  $p(u)$

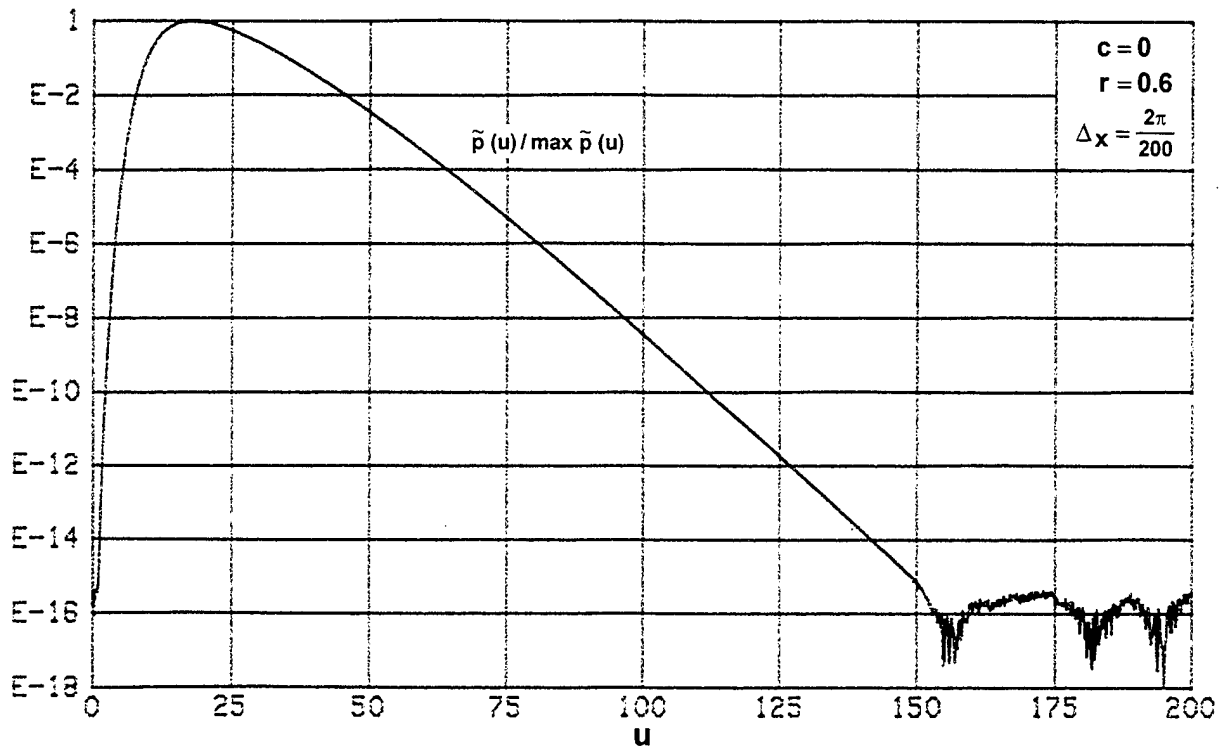


Figure 8. Essential Singularity  $\tilde{p}(u)$

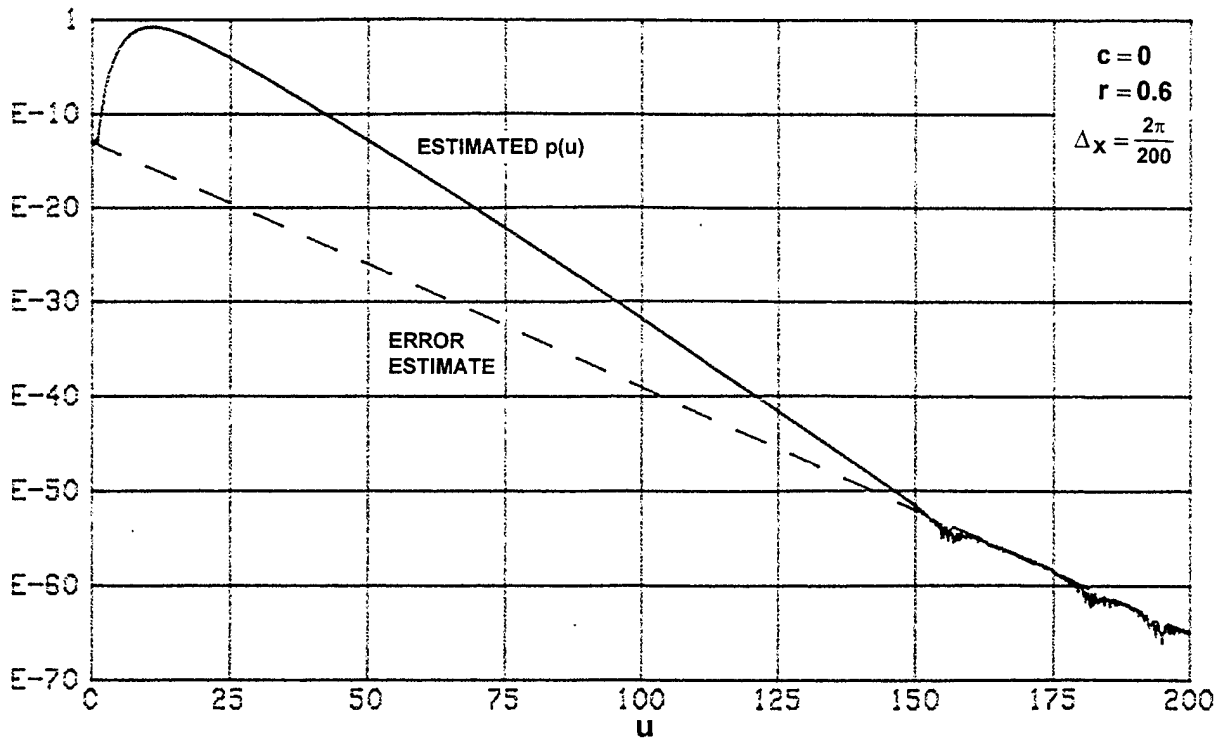


Figure 9. Essential Singularity  $p(u)$

## CHI-SQUARE EDF

The CF of interest is again  $f(\xi) = (1 - i\xi)^{-10}$ . However, for the following examples, the quantity of interest is the EDF  $E(u)$ . For sampling increment  $\Delta_x = 2\pi/240$ , shift  $r = 0.6$ , and additive constant  $c = 0$ , the periodic function  $\tilde{E}(u)$  of equations (21) and (24) is presented in figure 10. The nonzero values of  $\tilde{E}(u)$  just below  $u = 240$  are the nonzero values of  $E(u)$  for  $u < 0$  being periodically repeated; this exponential decay of  $E(u)$ , according to equation (20), shows up as a straight line on the logarithmic ordinate. The relative error of  $\tilde{E}(u)$  in figure 10 in the noisy region is  $E-15$ .

For this example, take the noise-region integer of equation (25) as  $N_f = 0.75 N = 768$ . Then, the estimated EDF  $E(u)$ , obtained from equations (25) and (26), is presented in figure 11. For  $u$  less than 150, the estimated and exact EDFs overlap. Also, for  $200 < u < 240$ , the estimated  $E(u)$  recovers its correct value of 1; recall that this region corresponds to  $u < 0$  in the original  $E(u)$ .

The accuracy of estimated EDF  $E(u)$  is about five decimals at the  $E-40$  probability level. The error estimate (dashed line) is obtained by drawing a straight line between the noisy regions established in figure 10; the white-noise level in figure 10 is translated by equations (23) or (25) into a line with slope  $-r \log(e) = -0.434 r$  on the logarithmic ordinate of figure 11.

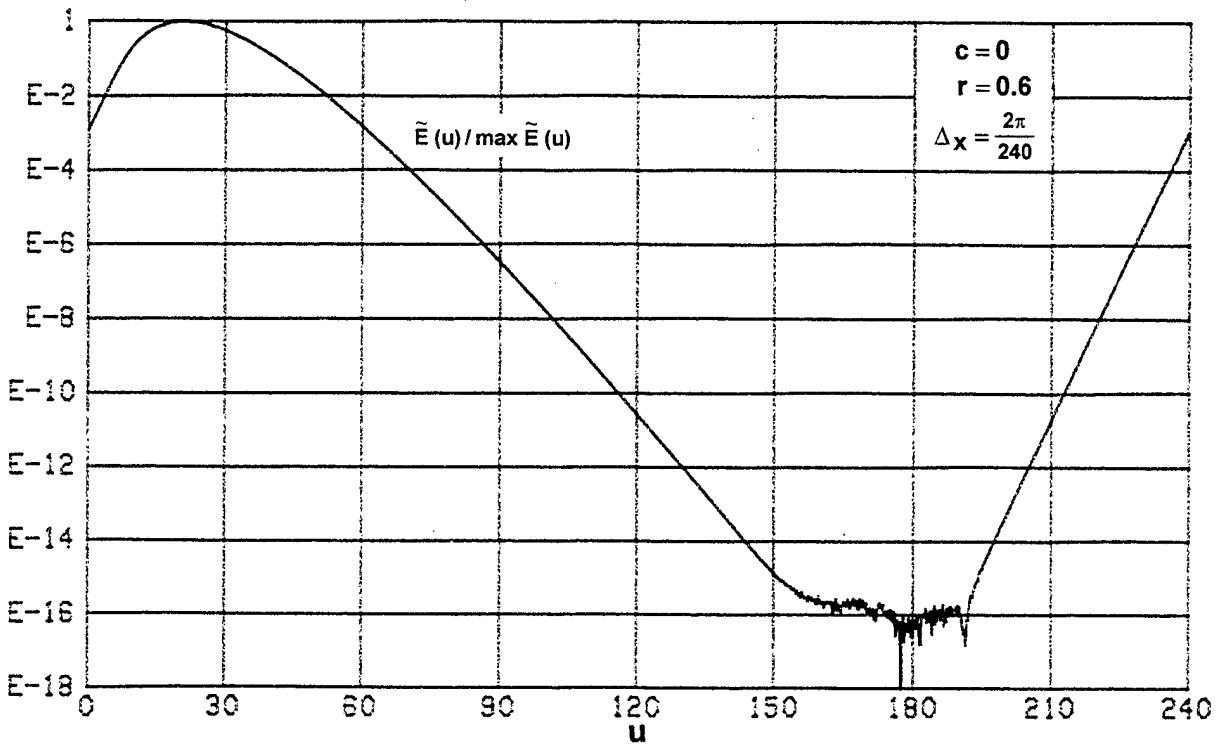


Figure 10. Chi-Square  $\tilde{E}(u)$

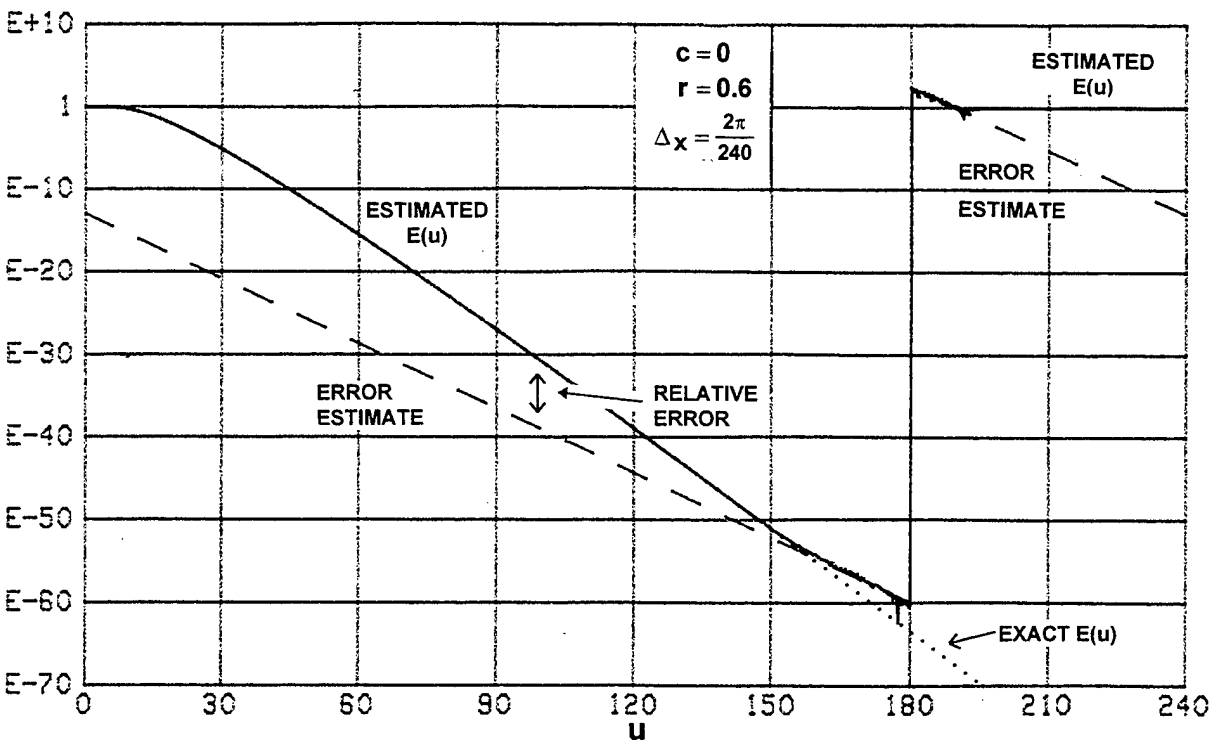


Figure 11. Chi-Square  $E(u)$

## GAUSSIAN EDF

The CF for this example is  $f(\xi) = \exp(-\xi^2/2 + ic\xi)$ , where constant  $c$  is taken as 6. For increment  $\Delta_x = 2\pi/24$  and shift  $r = 5$ , the periodic function  $\tilde{E}(u)$  is as displayed in figure 12. For noise-region integer  $N_f = 7/8 N = 896$ , the corresponding estimated  $E(u)$  is plotted in figure 13. The stability is approximately six decimals at the E-30 probability level. The estimated  $E(u)$  never recovers its unity value for  $u$  just less than 24 because the periodic function in figure 12 was not noise-free in that region (in contrast to figures 10 and 11).

## BRANCH POINT EDF

The CF  $f(\xi)$  was given in equation (27). The increment  $\Delta_x$  must be taken smaller for the EDF than for the PDF because of the "left" tail of  $\underline{E}(u)$  for  $u < 0$ ; see equation (20). On the other hand, the number of samples decreased to about 60,000 because of the extra  $1/\xi$  decay factor in equations (18) and (21). The periodic function  $\tilde{E}(u)$  is given in figure 14. The left tail of  $\underline{E}(u)$  shows up in the region  $200 < u < 240$ .

The corresponding estimated EDF  $E(u)$  is displayed in figure 15. It has seven significant digits at the E-40 probability level. The error estimate has slope  $-0.434 r$ , which is  $-0.35$  for this example where  $r = 0.8$  has been used.

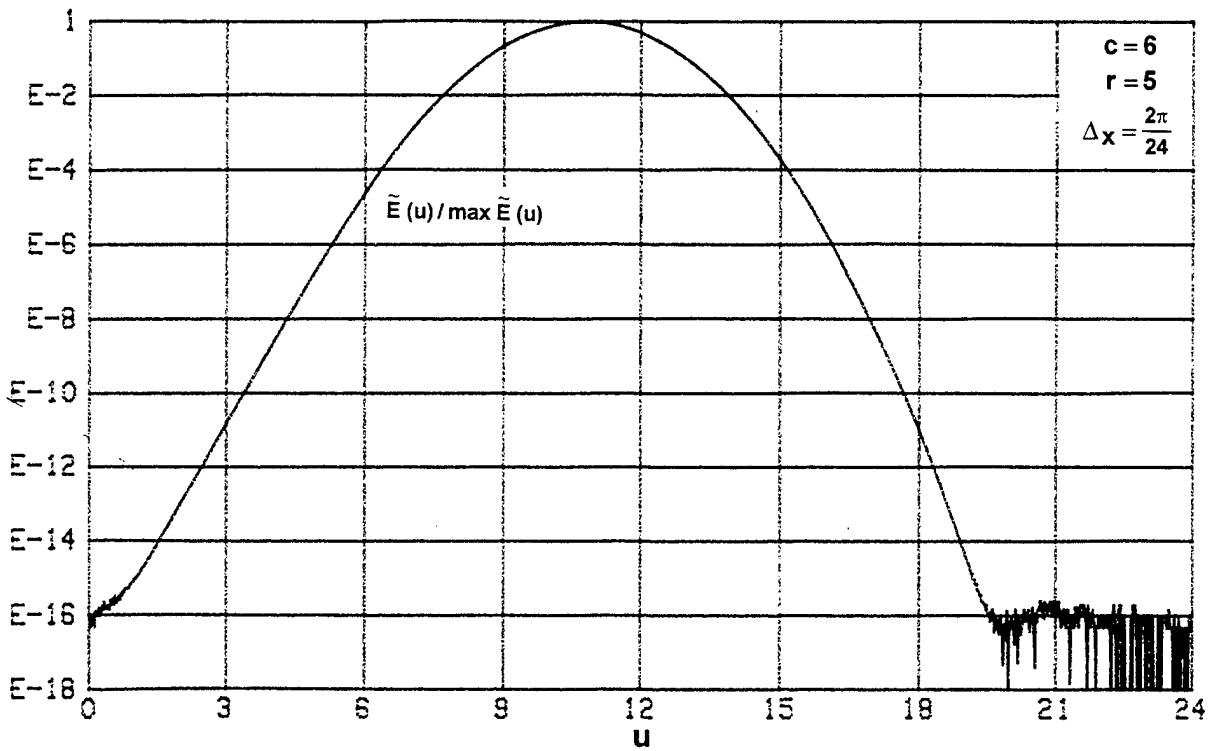


Figure 12. Gaussian  $\tilde{E}(u)$

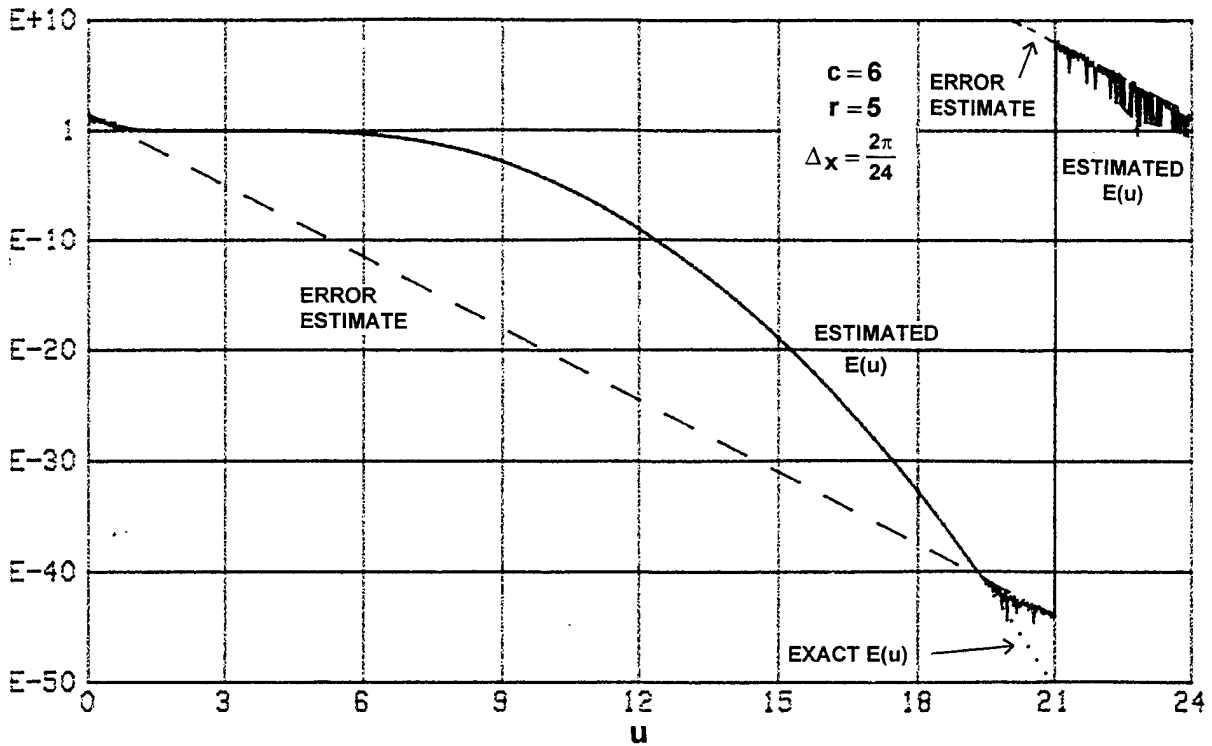


Figure 13. Gaussian  $E(u)$

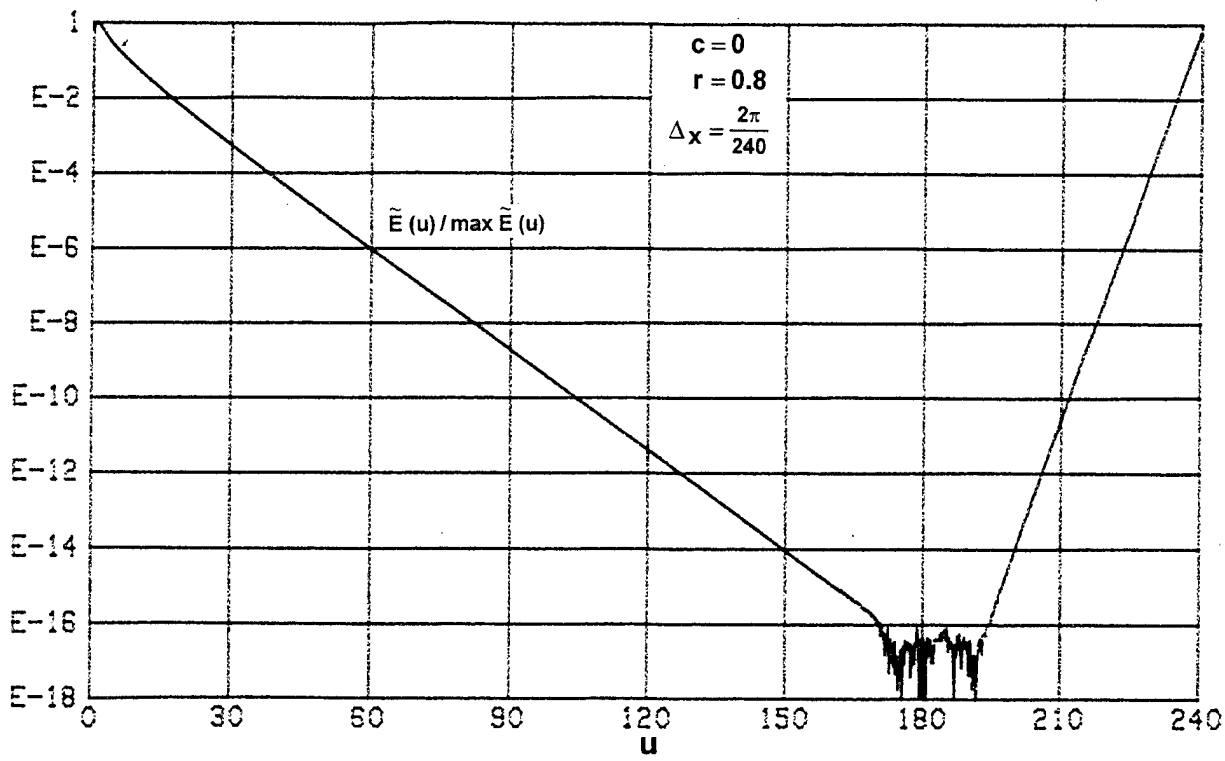


Figure 14. Branch Point  $\tilde{E}(u)$

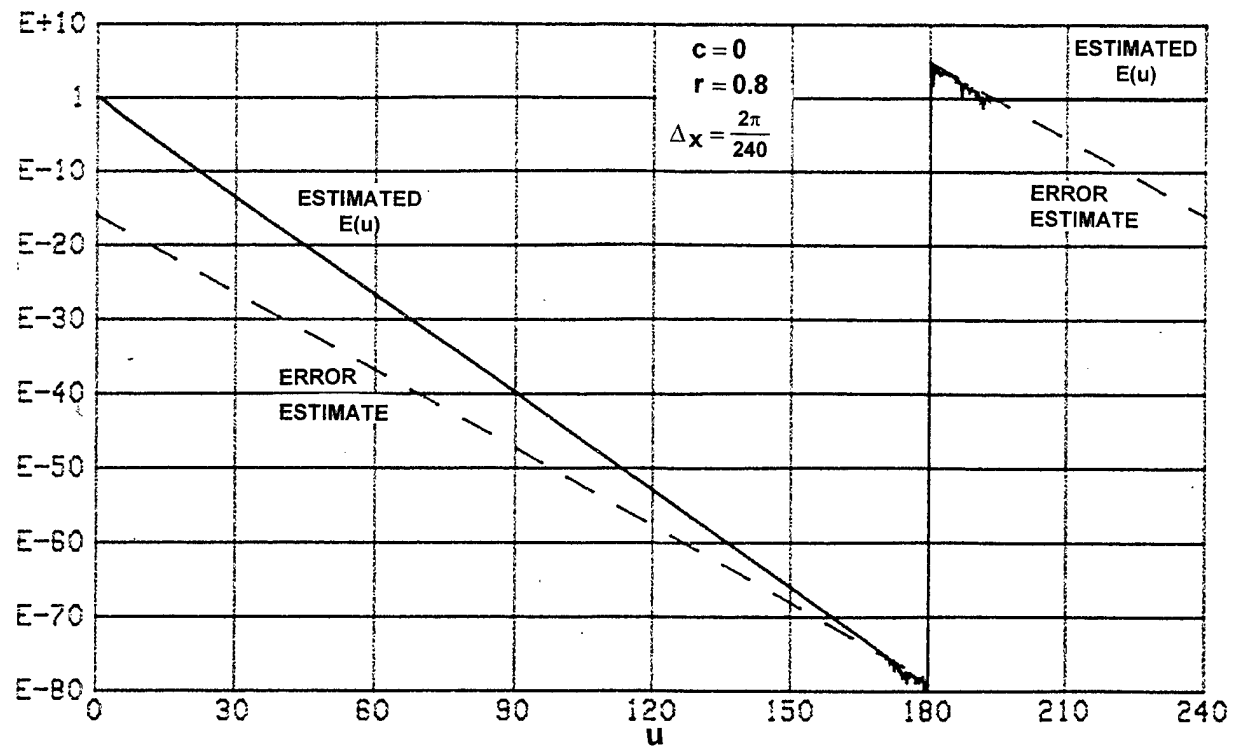


Figure 15. Branch Point  $E(u)$

## ESSENTIAL SINGULARITY EDF

The CF for this example is given by equation (28). The exponential decay of  $f(\xi)$  allows accurate calculation of the periodic function  $\tilde{E}(u)$  with just over 200 samples of the CF. The left tail in figure 16, just below  $u = 240$ , is again the periodic repetition of the exponential behavior of  $\underline{E}(u)$  for  $u < 0$ , as indicated in equation (20).

The corresponding estimated EDF  $E(u)$  is given in figure 17, along with an error estimate that has a slope of  $-0.434 * 0.6 = -0.26$  for  $r = 0.6$  in this example. There are approximately four digits of significance in  $E(u)$  at the  $E-40$  probability level.

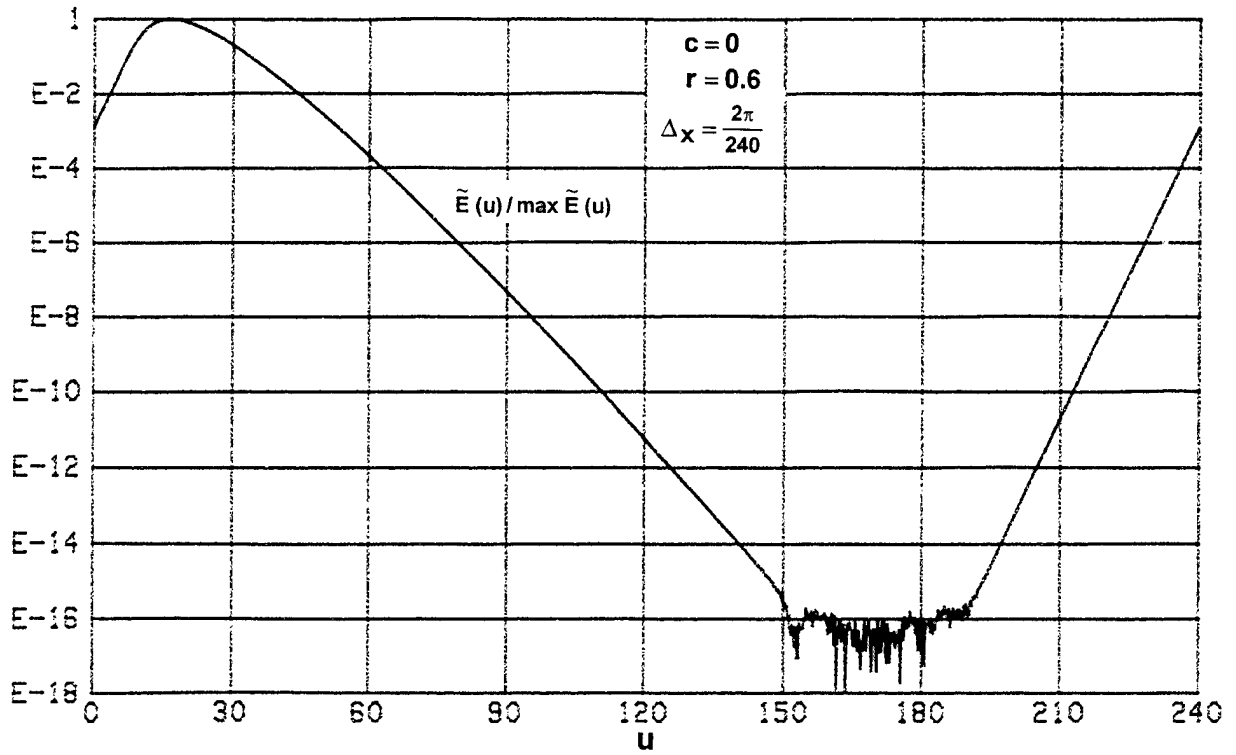


Figure 16. Essential Singularity  $\tilde{E}(u)$

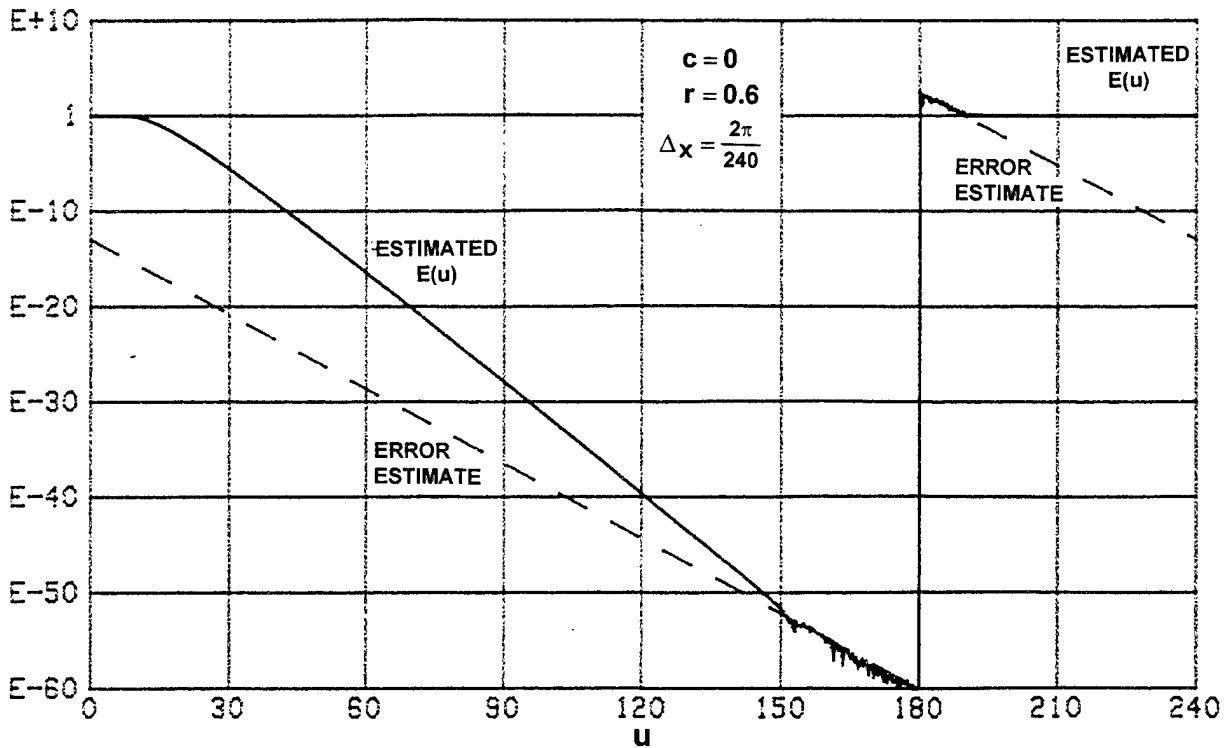


Figure 17. Essential Singularity  $E(u)$

## SUMMARY

An efficient, fast, and accurate FFT technique for obtaining small tail probabilities for both the PDF and the EDF, directly from the CF, has been derived and demonstrated numerically for several examples. The method is especially useful when analytic or asymptotic expressions for the probabilities are unavailable or unknown.

By choosing the shift parameter  $r$  closer to the highest singularity of CF  $f(\xi)$  in the complex  $\xi$ -plane, smaller values of the tail probabilities of the PDF and EDF can be realized. The cost in this approach is that the sampling increment  $\Delta_x$  must then be taken smaller to avoid aliasing. Although taking a smaller  $\Delta_x$  necessitates more computer time and effort, it does not have to involve more storage because prealiasing can be advantageously employed to keep the FFT size  $N$  at very reasonable values. The FFT size  $N$  has no effect upon the errors caused by aliasing and truncation; rather,  $N$  merely controls the spacing at which the PDF and EDF outputs are calculated.

A sample BASIC program for calculating the PDF  $p(u)$  is listed in appendix A, and the corresponding program for the EDF  $E(u)$  is given in appendix B. Inputs required of the user are additive constant  $c$ , shift  $r$ , sampling increment  $\Delta_x$ , and the particular CF  $f(\xi)$ . Some trial and error may be necessary in selecting the best values of  $r$  and  $\Delta_x$ .

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2. A. H. Nuttall, "Accurate Efficient Evaluation of Cumulative or Exceedance Probability Distributions Directly from Characteristic Functions," NUSC Technical Report 7023, Naval Underwater Systems Center, New London, CT, 1 October 1983.
3. A. H. Nuttall, "Numerical Evaluation of Cumulative Probability Distribution Functions Directly from Characteristic Functions," **Proceedings of the Institute of Electrical and Electronics Engineers**, volume 57, number 11, pages 2071 - 2072, November 1969.
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## APPENDIX A — BASIC PROGRAM FOR PDF

```

10 ! SMALL TAIL PROBABILITIES           "CHI-SQUARE-PDF"
20 R=.7                                ! AMOUNT OF CONTOUR SHIFT USED
30 Dx=2.*PI/240.                       ! SAMPLING INCREMENT IN X
40 C=0.                                  ! ADDITIVE CONSTANT
50 N=1024                                ! SIZE OF FFT
60 Y1=-90.                              ! LOWER LIMIT OF LGT RANGE
70 Y2=0.                                  ! UPPER LIMIT OF LGT RANGE
80 Tol=1.E-36                           ! TOLERANCE ON MAG SQ CHAR FN
90 N1=N-1
100 REDIM Cos(0:N/4),X(0:N1),Y(0:N1)
110 DIM Cos(4096),X(16384),Y(16384)
120 DOUBLE N,N1,K,M,Ns                 ! INTEGERS, NOT DOUBLE PRECISION
130 A=2.*PI/N
140 FOR K=0 TO N/4
150 Cos(K)=COS(A*K)                    ! QUARTER-COSINE TABLE IN Cos(*)
160 NEXT K
170 A1=10.                              ! CF  $f(x_i) = 1/(1 - i x_i)^{\alpha}$ 
180 R1=1.-R
190 F0=1./R1^A1
200 X(0)=.5
210 Y(0)=0.
220 M=0
230 M=M+1
240 X=Dx*M
250 CALL Power(R1,-X,-A1,Ar,Ai)
260 Fr=Ar/F0                             ! REAL CF
270 Fi=Ai/F0                             ! IMAG CF
280 K=M MODULO N                        ! PREALIASING
290 X(K)=X(K)+Fr
300 Y(K)=Y(K)+Fi
310 IF (Fr*Fr+Fi*Fi>Tol) THEN 230
320 CALL Fft14(N,Cos(*),X(*),Y(*))
330 MAT X=X*(Dx/PI)
340 Big=MAX(X(*))
350 GINIT
360 PLOTTER IS "GRAPHICS"
370 GRAPHICS ON
380 WINDOW 0,N,-18,0
390 LINE TYPE 3
400 GRID N/8,2
410 LINE TYPE 1
420 FOR Ns=0 TO N1
430 Pn=X(Ns)                             ! PDF TILDA
440 IF Pn<>0. THEN 470
450 PENUP
460 GOTO 480
470 PLOT Ns,LGT(ABS(Pn)/Big)             ! NORMALIZED PDF TILDA
480 NEXT Ns
490 PENUP
500 PAUSE

```

```

510     Du=2.*PI/(N*Dx)           ! U INCREMENT
520     FOR Ns=0 TO N1
530     U=Du*Ns
540     X(Ns)=F0*EXP(-R*U)*X(Ns) ! PDF ESTIMATE
550     NEXT Ns
560     GCLEAR
570     WINDOW 0,N,Y1,Y2
580     LINE TYPE 3
590     GRID N/8,10
600     A1=A1-1.
610     Ga=FNGamma(A1)
620     FOR Ns=1 TO N STEP 10
630     U=Du*Ns
640     Pe=FNEX(U-A1*LOG(U))/Ga   ! PDF EXACT
650     PLOT Ns,LGT(Pe)
660     NEXT Ns
670     PENUP
680     PAUSE
690     LINE TYPE 1
700     FOR Ns=0 TO N1
710     Pn=X(Ns)                 ! PDF ESTIMATE
720     IF Pn<>0. THEN 750
730     PENUP
740     GOTO 760
750     PLOT Ns,LGT(ABS(Pn))
760     NEXT Ns
770     LINE TYPE 3
780     MOVE 0,LGT(ABS(X(0)))     ! ERROR
790     DRAW N1,LGT(ABS(X(N1)))   ! ESTIMATE
800     PENUP
810     PAUSE
820     END
830     !
840     DEF FNEX(X)               ! EXP(-X)
850     IF X>708. THEN RETURN 0.
860     RETURN EXP(-X)
870     FNEND
880     !
890     SUB Power(X,Y,Real,U,V)   ! PRINCIPAL POWER Z^Real
900     T=X*X+Y*Y
910     IF T>0. THEN 950
920     U=V=0.
930     IF Real=0. THEN U=1.
940     SUBEXIT
950     F=EXP(.5*Real*LOG(T))
960     IF X=0. THEN A=.5*PI*SGN(Y)
970     IF X<>0. THEN A=ATN(Y/X)
980     IF X<0. THEN A=A+PI*(1.-2.*(Y<0.))
990     T=Real*A
1000    U=F*COS(T)
1010    V=F*SIN(T)
1020    SUBEND
1030    !
1040    DEF FNGamma(X)           ! HART, page 135, #5243
1070    !
1380    SUB Fft14(DOUBLE N,REAL Cos(*),X(*),Y(*)) ! N<=2^14=16384; 0 SUBS

```

## APPENDIX B — BASIC PROGRAM FOR EDF

```

10 ! SMALL TAIL PROBABILITIES          "CHI-SQUARE-EDF"
20 Dx=2.*PI/240.          ! SAMPLING INCREMENT IN X
30 R=.6                    ! AMOUNT OF CONTOUR SHIFT USED
40 N=1024                  ! SIZE OF FFT
50 Y1=-70.                ! LOWER LIMIT OF LGT RANGE
60 Y2=10.                 ! UPPER LIMIT OF LGT RANGE
70 Tol=1.E-30             ! TOLERANCE ON MAG SQ CHAR FN
80 N1=N-1
90 REDIM Cos(0:N/4),X(0:N1),Y(0:N1)
100 DIM Cos(4096),X(16384),Y(16384)
110 DOUBLE N,N1,K,M,Ns,Nf ! INTEGERS, NOT DOUBLE PRECISION
120 A=2.*PI/N
130 FOR K=0 TO N/4
140 Cos(K)=COS(A*K)        ! QUARTER-COSINE TABLE IN Cos(*)
150 NEXT K
160 MAT X=(0.)
170 MAT Y=(0.)
180 A1=10.                 ! CF f(xi) = 1/(1 - i xi)^alpha
190 R1=1.-R
200 R2=R*R
210 X(0)=.5/(R1^A1*R)
220 M=0
230 M=M+1
240 X=Dx*M
250 CALL Power(R1,-X,-A1,Ar,Ai)
260 A=R2+X*X
270 Fr=(Ar*R+Ai*X)/A      ! REAL CF
280 Fi=(Ai*R-Ar*X)/A      ! IMAG CF
290 K=M MODULO N          ! PREALIASING
300 X(K)=X(K)+Fr
310 Y(K)=Y(K)+Fi
320 IF (Fr*Fr+Fi*Fi)>Tol THEN 230
330 CALL Fft14(N,Cos(*),X(*),Y(*))
340 MAT X=X*(Dx/PI)
350 Big=MAX(X(*))
360 GINIT
370 PLOTTER IS "GRAPHICS"
380 GRAPHICS ON
390 WINDOW 0,N,-18,0
400 LINE TYPE 3
410 GRID N/8,2
420 LINE TYPE 1
430 FOR Ns=0 TO N1
440 En=X(Ns)              ! EDF TILDA
450 IF En<>0. THEN 480
460 PENUP
470 GOTO 490
480 PLOT Ns,LGT(ABS(En)/Big) ! NORMALIZED EDF TILDA
490 NEXT Ns
500 PENUP

```

```

510     INPUT "INPUT FRACTION OF PERIOD",Frac
520     Nf=N*Frac
530     Du=2.*PI/(N*Dx)           ! U INCREMENT
540     FOR Ns=0 TO Nf
550     U=Du*Ns
560     X(Ns)=EXP(-R*U)*X(Ns)    ! EDF E(u)
570     NEXT Ns
580     Rp=R*2.*PI/Dx
590     FOR Ns=Nf+1 TO N1
600     U=Du*Ns
610     X(Ns)=EXP(-R*U+Rp)*X(Ns) ! EDF E(u)
620     NEXT Ns
630     GCLEAR
640     WINDOW 0,N,Y1,Y2
650     LINE TYPE 3
660     GRID N/8,10
670     A1=A1-1.
680     Ga=FNGamma(A1)
690     FOR Ns=0 TO N STEP 10
700     U=Du*Ns
710     S=T+1.
720     FOR K=1 TO A1
730     T=T*U/K
740     S=S+T
750     NEXT K
760     Ee=EXP(-U)*S             ! EDF EXACT
770     IF Ee>0. THEN 800
780     PENUP
790     GOTO 810
800     PLOT Ns,LGT(Ee)
810     NEXT Ns
820     PENUP
830     LINE TYPE 1
840     FOR Ns=0 TO N1
850     En=X(Ns)                 ! ESTIMATED EDF
860     IF En<>0. THEN 890
870     PENUP
880     GOTO 900
890     PLOT Ns,LGT(ABS(En))
900     NEXT Ns
910     PENUP
920     PAUSE
930     GRAPHICS OFF
940     END
950     !
960     SUB Power(X,Y,Real,U,V)   ! PRINCIPAL POWER Z^Real
1100    !
1110    DEF FNGamma(X)           ! HART, page 135, #5243
1440    !
1450    SUB Fft14(DOUBLE N,REAL Cos(*),X(*),Y(*)) ! N<=2^14=16384; 0 SUBS

```

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